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Application/Control No.	Applicant(s)/Patent under Reexamination
09/674,648	FURCHHEIM ET AL.
Examiner	Art Unit
Chong H. Kim	3682

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Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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EAST text search		10/5/2006	СК
EAST text search		10/6/2006	СК
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